











SN74AHCT367

SCLS418H - JUNE 1998-REVISED DECEMBER 2014

## SN74AHCT367 Hex Buffer and Line Driver with 3-State Output

#### **Features**

- Inputs are TTL-Voltage Compatible
- True Outputs
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model
  - 200-V Machine Model
  - 2000-V Charged-Device Model

### **Applications**

- Telecom Infrastructure
- TVs
- Set Top Boxes
- **Network Switches**
- Wireless Infrastructure
- Electronic Points of Sale

### 3 Description

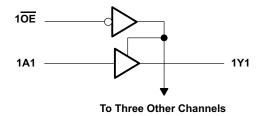
The SN74AHCT367 device is designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters.

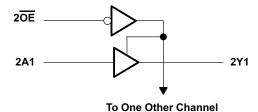
#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
	PDIP (16)	19.30 mm x 6.35 mm
	SSOP (16)	6.50 mm x 5.30 mm
SN74AHCT367	TSSOP (16)	5.00 mm x 4.40 mm
	SOP (16)	10.20 mm x 5.30 mm
	SOIC (16)	9.00 mm x 3.90 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

### **Simplified Schematic**







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### 5 Revision History

#### Changes from Revision G (July 2003) to Revision H

Page

Added Applications, Device Information table, Pin Functions table, ESD Ratings table, Thermal Information table, Typical Characteristics, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section.
 Deleted Ordering Information table.
 MAX operating temperature to 125°C in Recommended Operating Conditions table.

Product Folder Links: SN74AHCT367

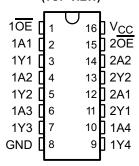
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# 6 Pin Configuration and Functions

# SN74AHCT367 . . . D, DB, DGV, OR PW PACKAGE (TOP VIEW)



#### **Pin Functions**

	PIN		
NO.	NAME	TYPE	DESCRIPTION
1	1 <del>OE</del>	I	Output Enable 1
2	1A1	I	1A1 Input
3	1Y1	0	1Y1 Output
4	1A2	I	1A2 Input
5	1Y2	0	1Y2 Output
6	1A3	1	1A3 Input
7	1Y3	0	1Y3 Output
8	GND	_	Ground Pin
9	1Y4	0	1Y4 Output
10	1A4	I	1A4 Input
11	2Y1	0	2Y1 Output
12	2A1	1	2A1 Input
13	2Y2	0	2Y2 Output
14	2A2	I	2A2 Input
15	2 <del>OE</del>	I	Output Enable 2
16	V <sub>CC</sub>	_	Power Pin



### 7 Specifications

#### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range		-0.5	7	٧
VI	Input voltage range (2)		-0.5	7	V
Vo	Output voltage range <sup>(2)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		-20	mA
I <sub>OK</sub>	Output clamp current	$V_O < 0$ or $V_O > V_{CC}$		±20	mA
Io	Continuous output current	$V_O = 0$ to $V_{CC}$		±25	mA
	Continuous current through V <sub>CC</sub> or GND			±75	mA
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### 7.2 ESD Ratings

			VALUE	UNIT
	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins (1)	2000		
V <sub>(ESD)</sub>	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	2000	V

<sup>1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

### 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

		SN74AHCT	367	LINUT
		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage	4.5	5.5	V
V <sub>IH</sub>	High-level input voltage	2		V
$V_{IL}$	Low-level Input voltage		0.8	V
VI	Input voltage	0	5.5	V
Vo	Output voltage	0	V <sub>CC</sub>	V
I <sub>OH</sub>	High-level output current		-8	mA
I <sub>OL</sub>	Low-level output current		8	mA
Δt/Δν	Input transition rise or fall rate		20	ns/V
T <sub>A</sub>	Operating free-air temperature	-40	125	°C

 All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs (SCBA004).

<sup>(2)</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



#### 7.4 Thermal Information

			SN74AHCT367					
	THERMAL METRIC <sup>(1)</sup>	D	DB	DGV	PW	UNIT		
			16	PINS				
$R_{\theta JA}$	Junction-to-ambient thermal resistance	85.1	103.9	124.5	111.5			
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	46.5	54.3	49.8	46.5			
$R_{\theta JB}$	Junction-to-board thermal resistance	42.6	54.6	56.2	56.6	°C/W		
$\Psi_{JT}$	Junction-to-top characterization parameter	13.2	14.3	5.8	5.8			
ΨЈВ	Junction-to-board characterization parameter	42.4	54.0	55.7	56.0			

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report (SPRA953).

#### 7.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST COMPLIANC	V	T <sub>A</sub>	= 25°C		-40°C to 8	85°C	-40°C to 1	25°C	LINUT
PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
V	I <sub>OH</sub> = -50 μA	4.5 V	4.4	4.5		4.4		4.4		V
$V_{OH}$	$I_{OH} = -8 \text{ mA}$	4.5 V	3.94			3.8		3.8		V
V	$I_{OL} = 50 \mu A$	4.5 V			0.1		0.1		0.1	V
$V_{OL}$	I <sub>OH</sub> = 8 mA	4.5 V			0.36		0.44		0.44	V
l <sub>l</sub>	V <sub>I</sub> = 5.5 V or GND	0 V to 5.5 V			±0.1 <sup>(1)</sup>		±1 <sup>(1)</sup>		±1	μA
I <sub>OZ</sub>	$V_O = V_{CC}$ or GND $V_I (\overline{OE}) = V_{IL}$ or $V_{IH}$	5.5 V			±0.25		±2.5		±2.5	μA
I <sub>cc</sub>	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			4		40		40	μA
ΔI <sub>CC</sub> <sup>(2)</sup>	One input at 3.4 V, Other inputs at V <sub>CC</sub> or GND	5.5 V			1.35		1.5		1.5	mA
$C_{i}$	V <sub>I</sub> = V <sub>CC</sub> or GND	5 V		2.5	10		10		10	pF
Co	$V_O = V_{CC}$ or GND	5 V		5						pF

#### 7.6 Switching Characteristics

over recommended operating free-air temperature range,  $V_{CC}$  = 5 V  $\pm$  0.5 V (unless otherwise noted) (see Figure 2)

PARAMETER	FROM	то	LOAD	T <sub>A</sub> = 25	5°C	–40°C to	85°C	–40°C to	125°C	UNIT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	TYP	MAX	MIN	MAX	MIN	MAX	UNII
t <sub>PLH</sub>	A	Υ	C <sub>1</sub> = 15 pF	2.5 <sup>(1)</sup>	4.8 <sup>(1)</sup>	1	6.5	1	8.5	ns
t <sub>PHL</sub>	A	T	C <sub>L</sub> = 15 pr	2.5 <sup>(1)</sup>	4.8 <sup>(1)</sup>	1	6.5	1	8.5	115
t <sub>PZH</sub>	ŌĒ	Υ	C 45 pF	3.5 <sup>(1)</sup>	8 <sup>(1)</sup>	1	9.5	1	9	
t <sub>PZL</sub>	OE	Ť	C <sub>L</sub> = 15 pF	2.8 <sup>(1)</sup>	7 <sup>(1)</sup>	1	8.5 <sup>(1)</sup>	1	8	ns
t <sub>PHZ</sub>	ŌĒ	Υ	0 45 -5	3.1 <sup>(1)</sup>	8 <sup>(1)</sup>	1	9.5	1	9	
t <sub>PLZ</sub>	OE .	Y	C <sub>L</sub> = 15 pF	2.8 <sup>(1)</sup>	7 <sup>(1)</sup>	1	8.5	1	8	ns
t <sub>PLH</sub>	^	Υ	0 50 - 5	3.5	5.8	1	7.5	1	9.5	
t <sub>PHL</sub>	A	Y	C <sub>L</sub> = 50 pF	3.3	5.8	1	7.5	1	9.5	ns
t <sub>PZH</sub>	ŌĒ	Υ	0 50 - 5	4.5	9	1	10.5	1	10	
t <sub>PZL</sub>	OE OE	Y	C <sub>L</sub> = 50 pF	3.7	8	1	9.5	1	9	ns
t <sub>PHZ</sub>	ŌĒ	Υ	C 50 = F	4.1	9	1	10.5	1	10	
t <sub>PLZ</sub>	OE .	Y	$C_L = 50 \text{ pF}$	3.6	8	1	9.5	1	9	ns

<sup>(1)</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.

<sup>(1)</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested at  $V_{CC} = 0 \text{ V}$ . (2) This is the increase in supply current for each input at one of the specified TTL voltage levels, rather than 0 V or  $V_{CC}$ .



#### 7.7 Noise Characteristics

 $V_{CC} = 5 \text{ V}, C_L = 50 \text{ pF}, T_A = 25^{\circ}C^{(1)}$ 

	DADAMETED		SN74AHCT367			
	PARAMETER	MIN	TYP	MAX	UNIT	
$V_{OL(P)}$	Quiet output, maximum dynamic V <sub>OL</sub>		0.4		V	
$V_{OL(V)}$	Quiet output, minimum dynamic V <sub>OL</sub>		-0.4		V	
$V_{OH(V)}$	Quiet output, minimum dynamic V <sub>OH</sub>		4.7		V	
$V_{IH(D)}$	High-level dynamic input voltage	2			V	
$V_{IL(D)}$	Low-level dynamic input voltage			0.8	V	

<sup>(1)</sup> Characteristics are for surface-mount packages only.

### 7.8 Operating Characteristics

 $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$ 

	PARAMETER		ONDITIONS	TYP	UNIT
$C_{pd}$	Power dissipation capacitance	No load,	f = 1 MHz	22	pF

### 7.9 Typical Characteristics

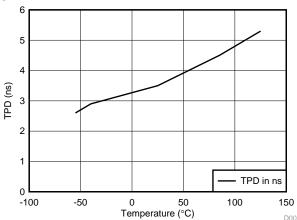
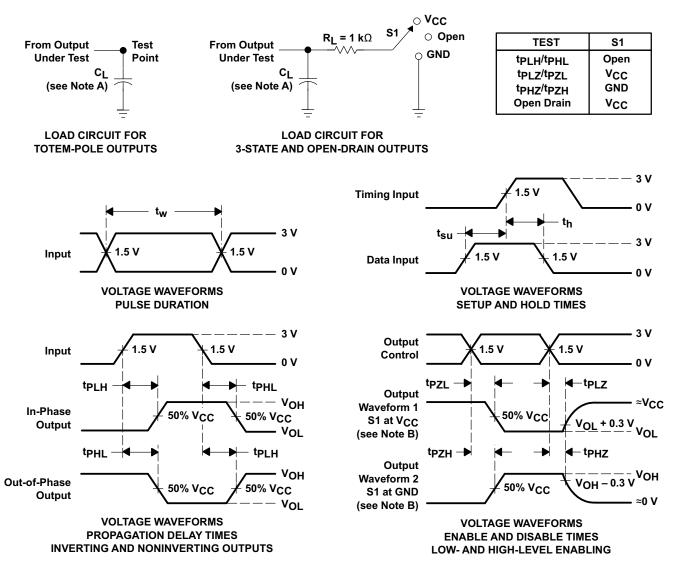


Figure 1. TPD vs Temperature, 50 pF Load



#### 8 Parameter Measurement Information



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O$  = 50  $\Omega$ ,  $t_f \leq$  3 ns.  $t_f \leq$  3 ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 2. Load Circuit and Voltage Waveforms



#### 9 Detailed Description

#### 9.1 Overview

The SN74AHCT367 device is designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. This device is organized as a dual 4-line and 2-line buffer/driver with active-low output-enable (1OE and 2OE) inputs. When OE is low, the device passes noninverted data from the A inputs to the Y outputs. When OE is high, the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pull-up resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

#### 9.2 Functional Block Diagram

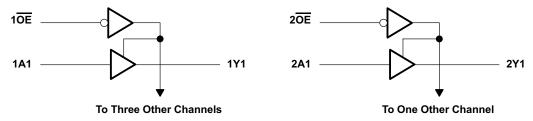


Figure 3. Logic Diagram (Positive Logic)

#### 9.3 Feature Description

- V<sub>CC</sub> is optimized at 5 V
- Allows up voltage translation from 3.3 V to 5 V
  - Inputs Accept V<sub>IH</sub> levels of 2 V
- · Slow edge rates minimize output ringing
- · Inputs are TTL-Voltage compatible

#### 9.4 Device Functional Modes

Table 1. Function Table (Each Buffer/Driver)

INP	UTS	OUTPUT
ŌĒ	Α	Υ
Н	X	Z
L	Н	Н
L	L	L



### 10 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 10.1 Application Information

SN74AHCT367 is a low-drive CMOS device that can be used for a multitude of bus interface type applications where output ringing is a concern. The low drive and slow edge rates will minimize overshoot and undershoot on the outputs. The input switching levels have been lowered to accommodate TTL inputs of 0.8-V  $V_{IL}$  and 2-V  $V_{IH}$ . This feature makes it Ideal for translating up from 3.3 V to 5 V. Figure 5 shows this type of translation.

#### 10.2 Typical Application

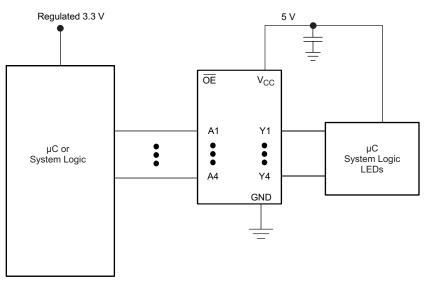


Figure 4. Typical Application Schematic

#### 10.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads, so routing and load conditions should be considered to prevent ringing.

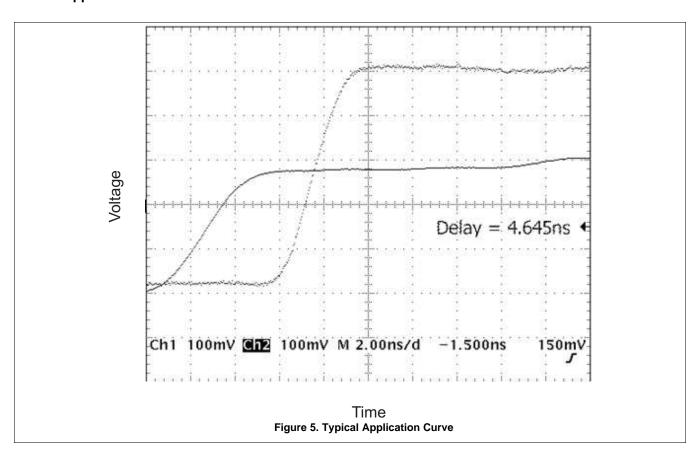
#### 10.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions
  - For rise time and fall time specifications, see  $\Delta t/\Delta V$  in the Recommended Operating Conditions table.
  - For specified High and low levels, see V<sub>IH</sub> and V<sub>IL</sub> in the Recommended Operating Conditions table.
  - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid V<sub>CC</sub>.
- 2. Recommend Output Conditions
  - Load currents should not exceed 25 mA per output and 75 mA total for the part.
  - Outputs should not be pulled above V<sub>CC</sub>.



### **Typical Application (continued)**

#### 10.2.3 Application Curves



#### 11 Power Supply Recommendations

The power supply can be any voltage between the MIN and MAX supply voltage rating located in the *Recommended Operating Conditions* table.

Each  $V_{CC}$  pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1  $\mu F$  is recommended. If there are multiple  $V_{CC}$  pins, 0.01  $\mu F$  or 0.022  $\mu F$  is recommended for each power pin. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. A 0.1  $\mu F$  and 1  $\mu F$  are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.



### 12 Layout

#### 12.1 Layout Guidelines

When using multiple bit logic devices, inputs should not float. In many cases, functions or parts of functions of digital logic devices are unused. Some examples are when only two inputs of a triple-input AND gate are used, or when only 3 of the 4-buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states.

Specified in Figure 6 are rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or  $V_{CC}$ , whichever makes more sense or is more convenient. It is acceptable to float outputs unless the part is a transceiver. If the transceiver has an output enable pin, it will disable the outputs section of the part when asserted. This will not disable the input section of the I/Os so they also cannot float when disabled.

#### 12.2 Layout Example

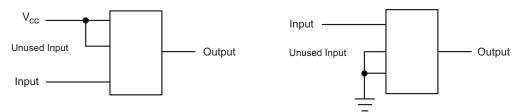


Figure 6. Layout Diagram

### 13 Device and Documentation Support

#### 13.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

**Table 2. Related Links** 

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
SN74AHCT367	Click here	Click here	Click here	Click here	Click here	

#### 13.2 Trademarks

All trademarks are the property of their respective owners.

#### 13.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 13.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

### 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





10-Dec-2020

#### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74AHCT367D	ACTIVE	SOIC	D	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHCT367	Samples
SN74AHCT367DBR	ACTIVE	SSOP	DB	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HB367	Samples
SN74AHCT367DGVR	ACTIVE	TVSOP	DGV	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HB367	Samples
SN74AHCT367DR	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHCT367	Samples
SN74AHCT367PW	ACTIVE	TSSOP	PW	16	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HB367	Samples
SN74AHCT367PWG4	ACTIVE	TSSOP	PW	16	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HB367	Samples
SN74AHCT367PWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HB367	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



### **PACKAGE OPTION ADDENDUM**

10-Dec-2020

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

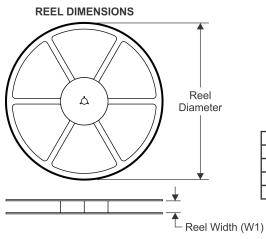
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### PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION





_		
		Dimension designed to accommodate the component width
	B0	Dimension designed to accommodate the component length
	K0	Dimension designed to accommodate the component thickness
	W	Overall width of the carrier tape
ı	P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

All differsions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AHCT367DBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74AHCT367DGVR	TVSOP	DGV	16	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
SN74AHCT367DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
SN74AHCT367PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AHCT367DBR	SSOP	DB	16	2000	853.0	449.0	35.0
SN74AHCT367DGVR	TVSOP	DGV	16	2000	853.0	449.0	35.0
SN74AHCT367DR	SOIC	D	16	2500	333.2	345.9	28.6
SN74AHCT367PWR	TSSOP	PW	16	2000	853.0	449.0	35.0

### D (R-PDS0-G16)

### PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



# D (R-PDSO-G16)

### PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





SMALL OUTLINE PACKAGE



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



### DGV (R-PDSO-G\*\*)

#### **24 PINS SHOWN**

#### **PLASTIC SMALL-OUTLINE**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194

### DB (R-PDSO-G\*\*)

### PLASTIC SMALL-OUTLINE

#### **28 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

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